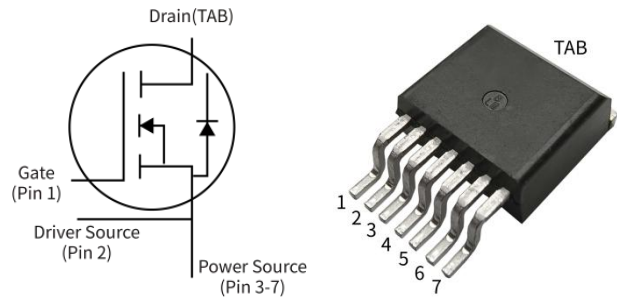


**Silicon Carbide Power MOSFET**

Parameter	Value	Unit
$V_{DS}$	1200	V
$I_D$	32	A
$R_{DS(ON)}$	80	m $\Omega$
$Q_G$	72	nC



TO-263-7L

**Features**

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low  $R_{DS(on)}$
- Low impedance package with driver source pin
- Easy to parallel and simple to drive

**Applications**

- EV Charging
- High Voltage DC/DC Converters
- Switched-Mode Power Supply(SMPS)
- Power Factor Correction(PFC)

**Absolute Maximum Ratings** (at  $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-source Voltage	$V_{DS}$	1200	V
Gate-source Voltage	$V_{GS}$	-10/+22	V
Drain Current (continuous; $T_c=25^\circ\text{C}$ )	$I_D$	32	A
Drain Current (continuous; $T_c=100^\circ\text{C}$ )		23	
Drain Current (pulsed)	$I_{DM}$	80	A
Power Dissipation ( $T_c=25^\circ\text{C}$ )	$P_D$	167	W
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to +175	$^\circ\text{C}$
Thermal Resistance from Junction to Case	$R_{\theta JC}$	0.9	$^\circ\text{C/W}$
Thermal Resistance From Junction to Ambient	$R_{\theta JA}$	40	

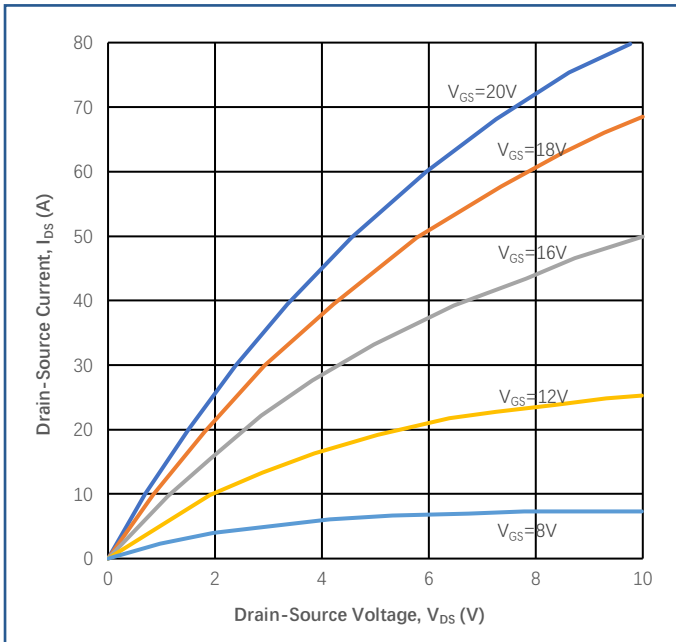
**Electrical Characteristics**

Parameter	Symbol	Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static characteristics</b> (at $T_C=25^\circ\text{C}$ unless otherwise specified)						
Drain-Source Breakdown Voltage	$B_{V_{DS}}$	$V_{GS}=0V; I_D=250\mu\text{A}$	1200	-	-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=1200V; V_{GS}=0V$	-	-	100	$\mu\text{A}$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=-10/+20V; V_{DS}=0V$	-	10	250	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}; I_{DS}=5\text{mA}$	2	3	4	V
Recommended Turn-on Voltage	$V_{GS(on)}$	Static	-	18	-	V
Recommended Turn-off Voltage	$V_{GS(off)}$		-	-5	-	V
Static Drain-Source on Resistance	$R_{DS(on)}$	$V_{GS}=18V; I_D=20A; T_J=25^\circ\text{C}$	-	80	100	m $\Omega$
		$V_{GS}=18V; I_D=20A; T_J=175^\circ\text{C}$	-	144	-	
<b>Dynamic characteristics</b> (at $T_C=25^\circ\text{C}$ unless otherwise specified)						
Input Capacitance	$C_{iss}$	$V_{DS}=1000V; f=1\text{MHz}; V_{AC}=25\text{mV}$	-	1455	-	pF
Output Capacitance	$C_{oss}$		-	78	-	
Reverse Transfer Capacitance	$C_{rss}$		-	3.5	-	
Transconductance	$g_{fs}$	$V_{DS}=20V; I_D=20A$	-	10	-	S
$C_{OSS}$ Stored Energy	$E_{OSS}$	$V_{DS}=1000V; f=1\text{MHz}$	-	35.7	-	$\mu\text{J}$
Turn-on Energy	$E_{on}$	$V_{DS}=800V; V_{GS}=-5/+18V; I_D=20A;$ $R_{g(ext)}=2.5\Omega; \text{Load}=150\mu\text{H}; T_J=175^\circ\text{C}$	-	460	-	$\mu\text{J}$
Turn-off Energy	$E_{off}$		-	120	-	
Total Gate Charge	$Q_G$	$V_{DS}=800V; V_{GS}=-5/+18V; I_D=15A$	-	72	-	nC
Gate-Source Charge	$Q_{GS}$		-	21	-	
Gate-Drain Charge	$Q_{GD}$		-	22	-	
Internal Gate Resistor	$R_{Gint}$	$f=1\text{MHz}; V_{AC}=25\text{mV}$	-	5.6	-	$\Omega$
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=800V; V_{GS}=-5/+18V; I_D=20A;$ $R_{g(ext)}=2.5\Omega; \text{Load}=150\mu\text{H}$	-	38	-	ns
Rise Time	$t_r$		-	13	-	
Turn-off Delay Time	$t_{d(off)}$		-	30	-	
Fall Time	$t_f$		-	10	-	

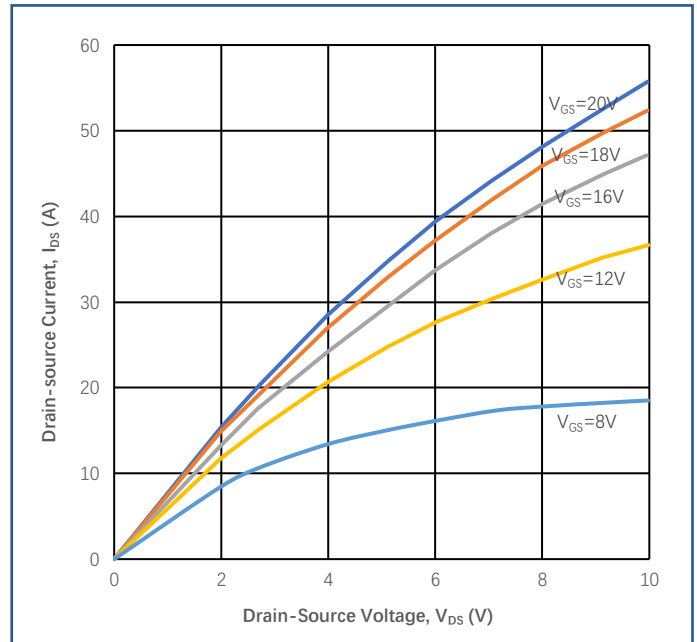
**Reverse SiC Diode Characteristics**(at  $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Diode Forward Voltage	$V_{FSD}$	$V_{GS}=0V; I_F=10A; T_J=25^\circ\text{C}$	-	3.9	6	V
		$V_{GS}=0V; I_F=10A; T_J=175^\circ\text{C}$	-	3.5	6	
Continuous Diode Forward Current	$I_S$	$V_{GS}=0V; T_C=25^\circ\text{C}$	-	27	-	A
Reverse Recovery Time	$t_{RR}$	$V_R=800V; V_{GS}=-5V; I_F=20A;$ $di/dt=900A/\mu\text{s}; T_J=175^\circ\text{C}$	-	32	-	ns
Reverse Recovery Charge	$Q_{RR}$		-	257	-	nC
Peak Reverse Recovery Current	$I_{RRM}$		-	12	-	A

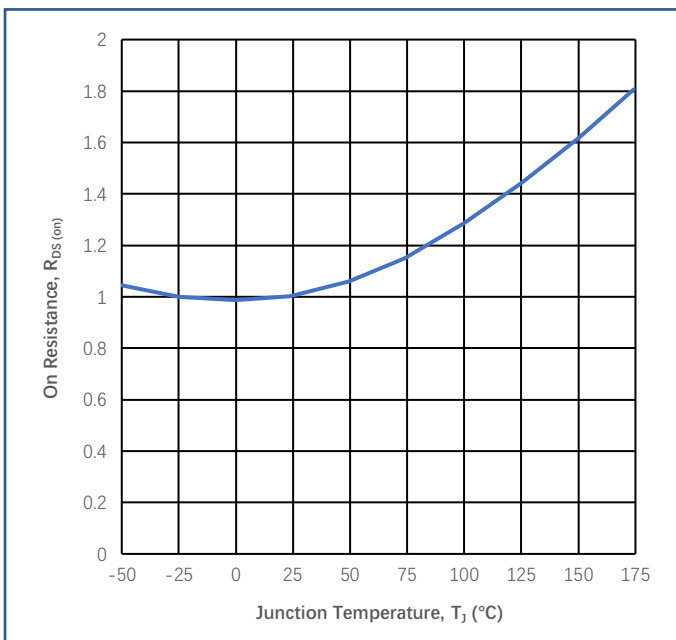
**Typical Characteristics**



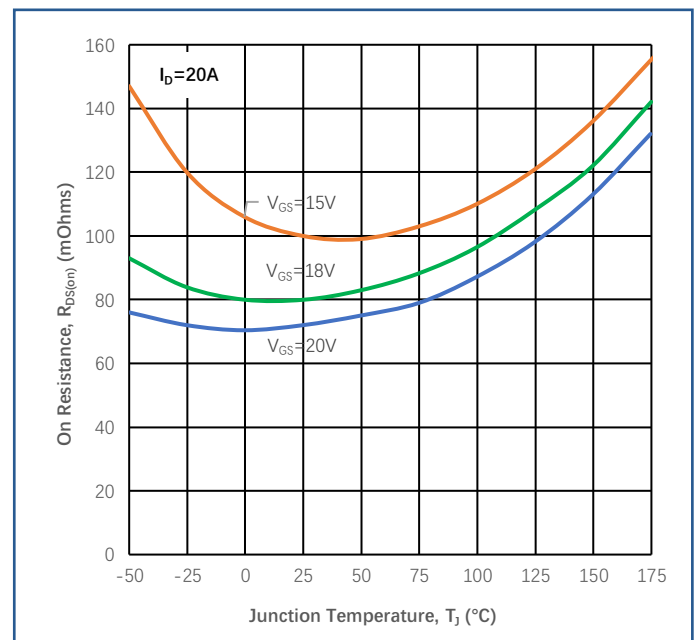
**Fig 1**  
Output Characteristics ( $T_J=25^\circ\text{C}$ )



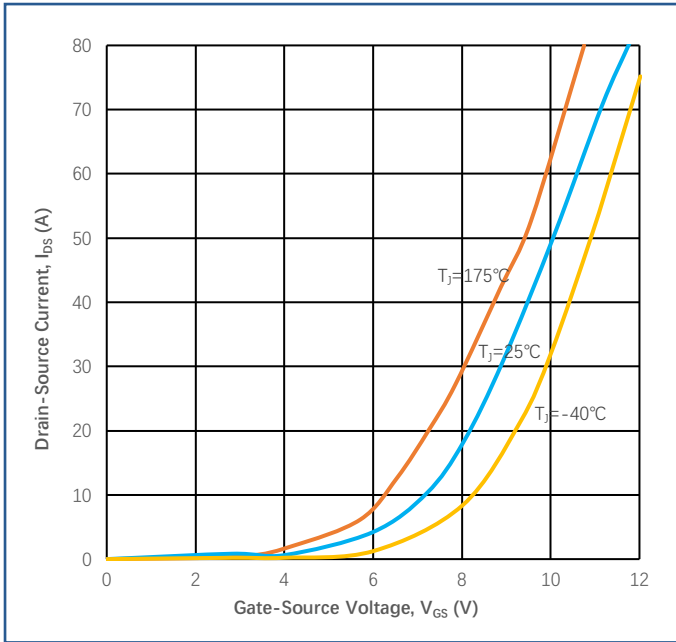
**Fig 2**  
Output Characteristics ( $T_J=175^\circ\text{C}$ )



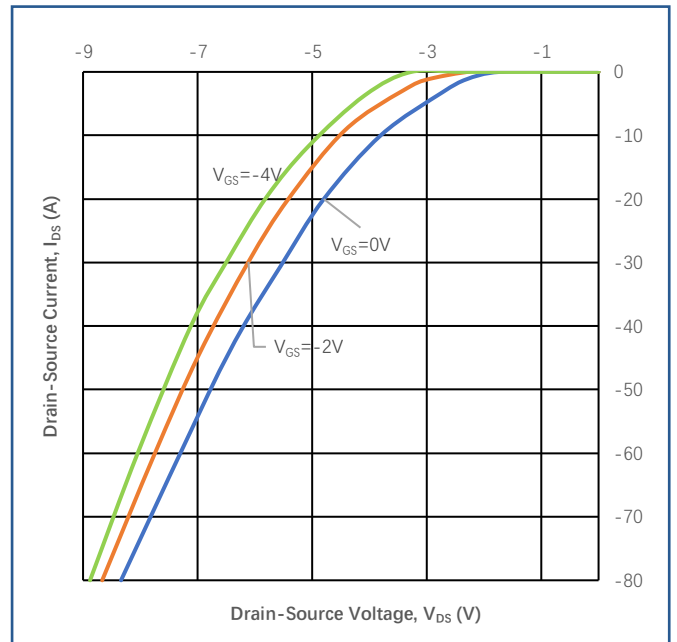
**Fig 3**  
Normalized On-Resistance vs. Temperature



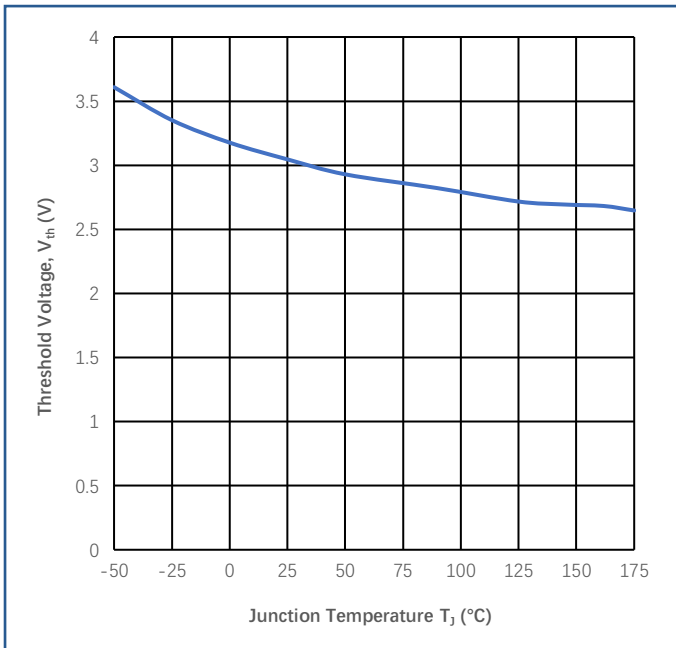
**Fig 4**  
On-Resistance vs. Temperature



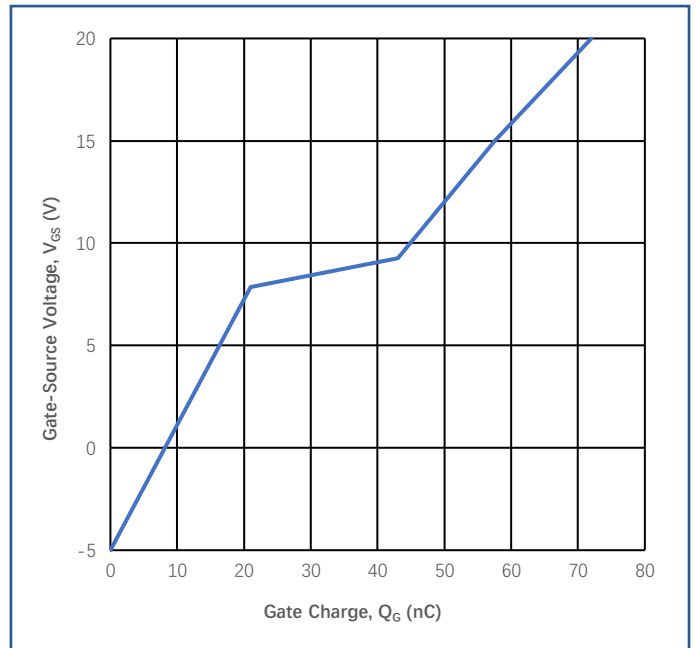
**Fig 5**  
 Transfer Characteristic



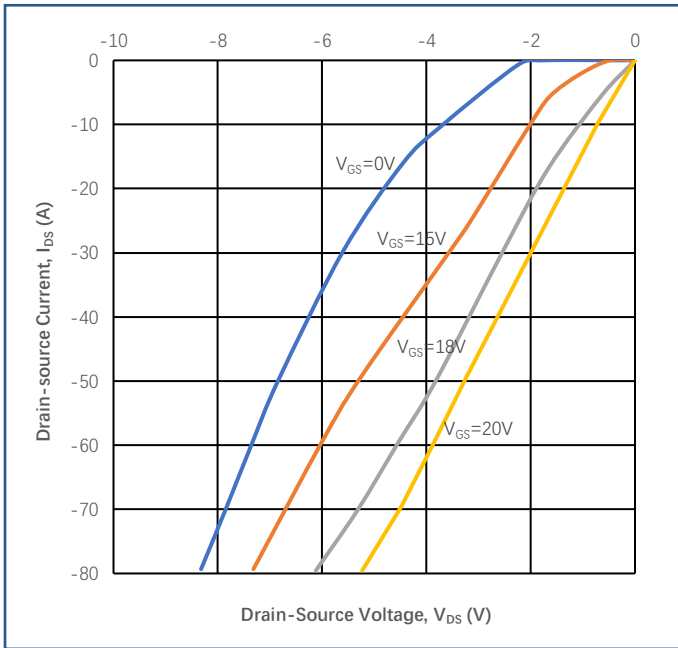
**Fig 6**  
 Body Diode Characteristic at  $25^\circ\text{C}$



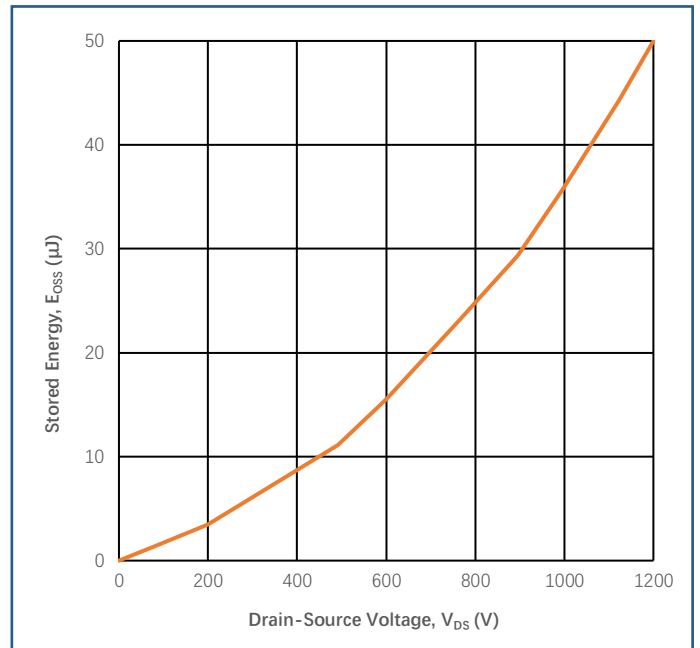
**Fig 7**  
 Threshold Voltage vs. Temperature



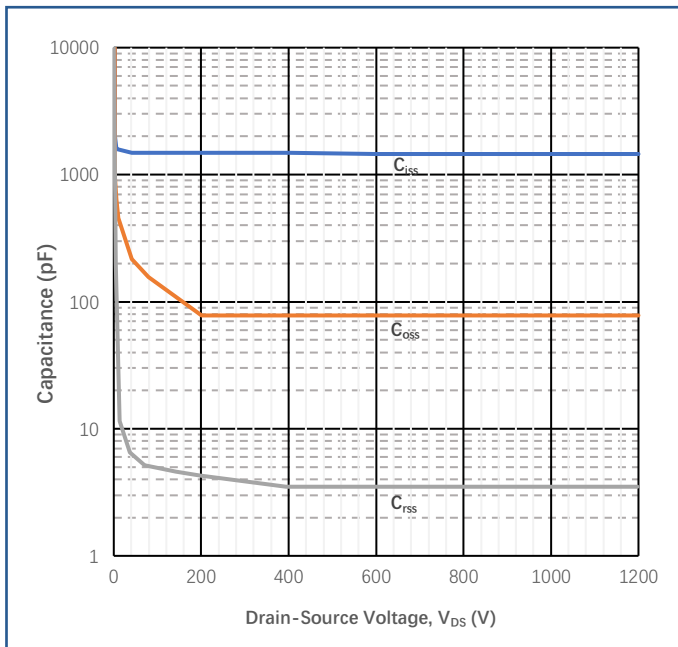
**Fig 8**  
 Gate Charge Characteristics



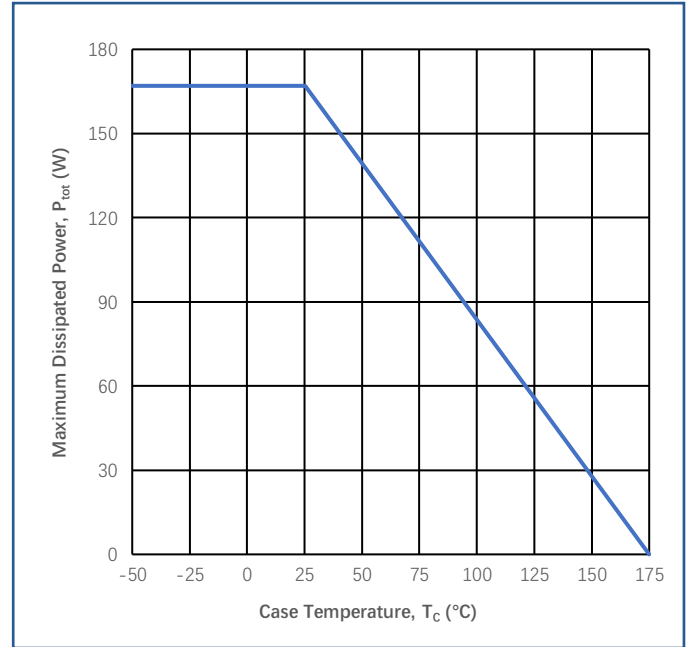
**Fig 9**  
3rd Quadrant Characteristic at 25°C



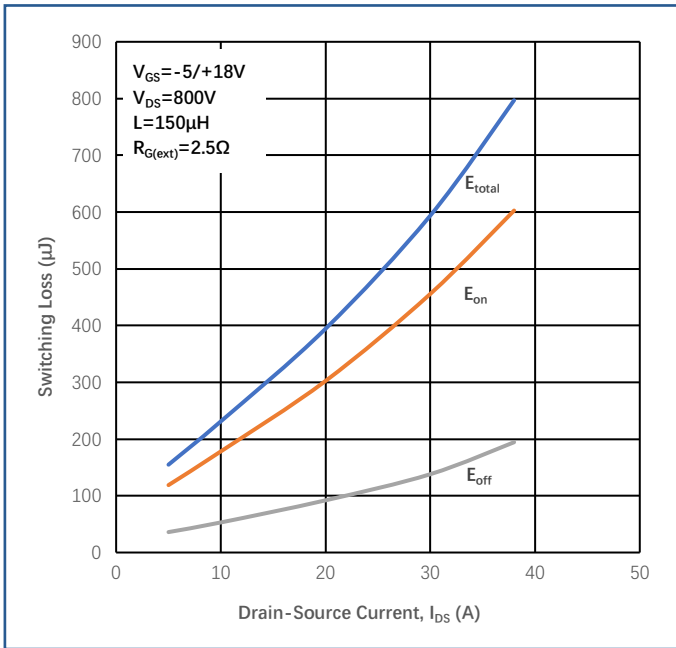
**Fig 10**  
Output Capacitor Stored Energy



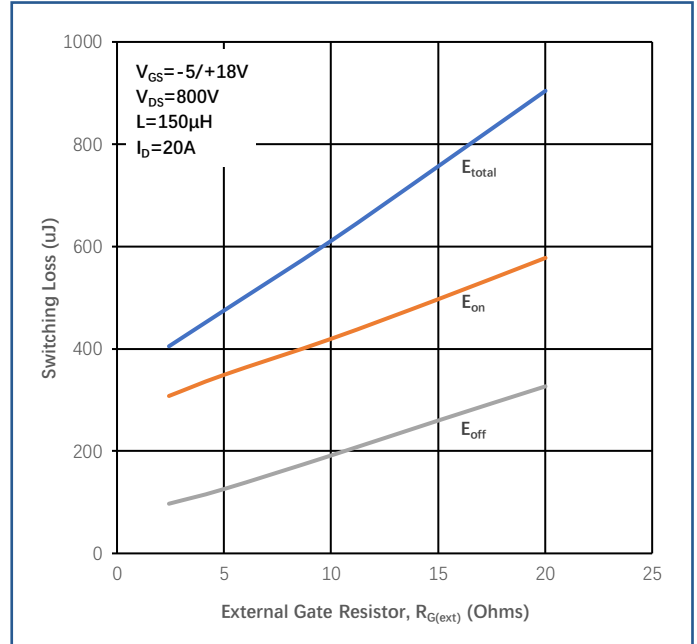
**Fig 11**  
Capacitances vs. Drain-Source



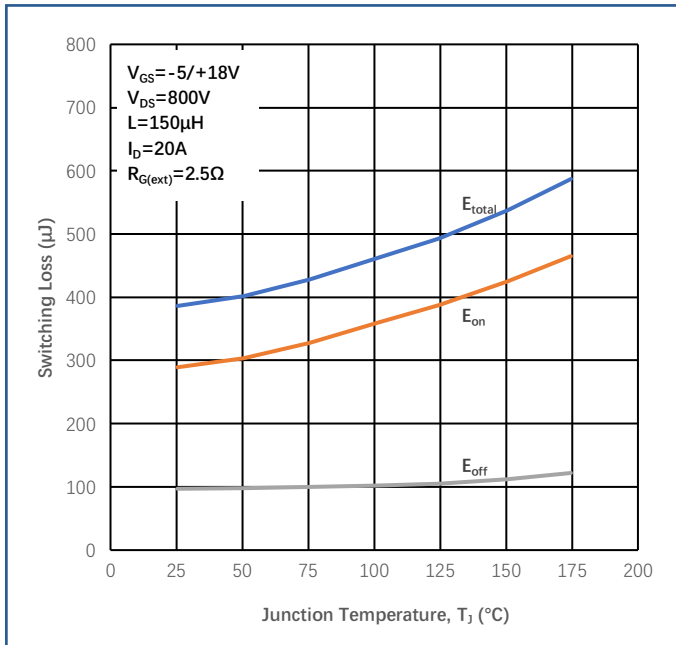
**Fig 12**  
Max Power Dissipation Derating vs  $T_C$



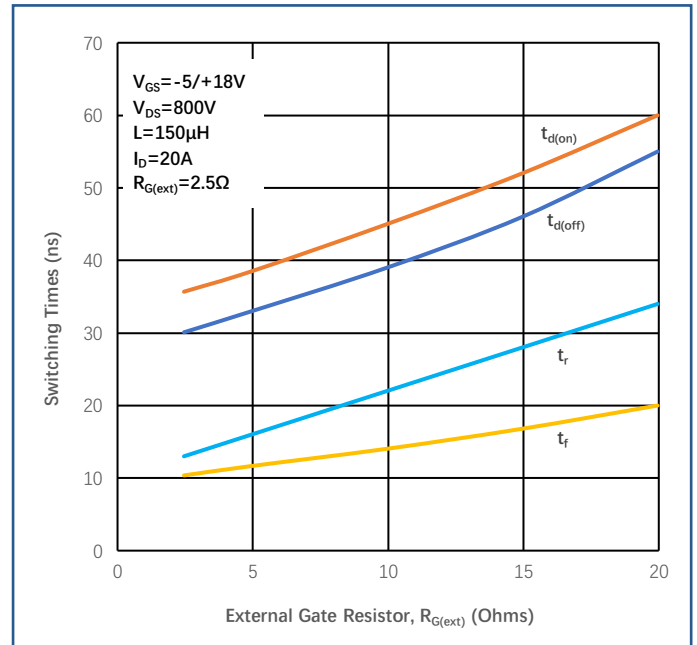
**Fig 13**  
Switching Energy vs. Drain Current



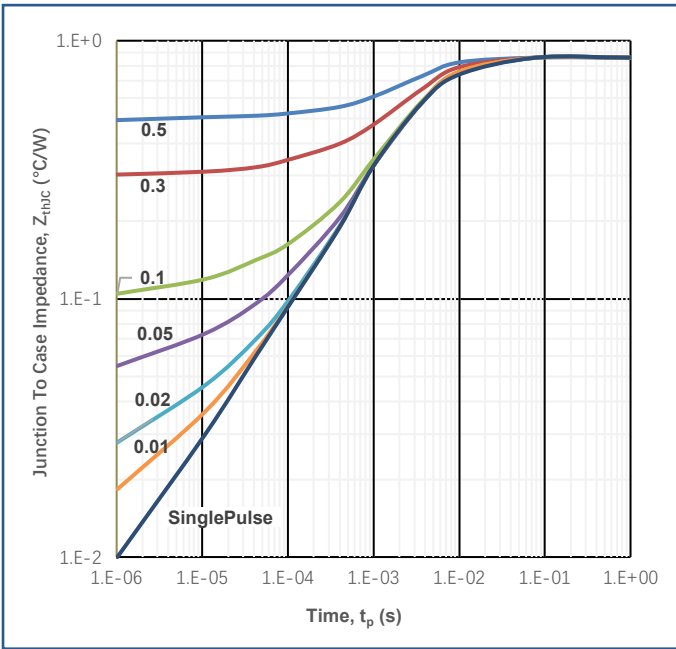
**Fig 14**  
Switching Energy vs.  $R_{G(\text{ext})}$



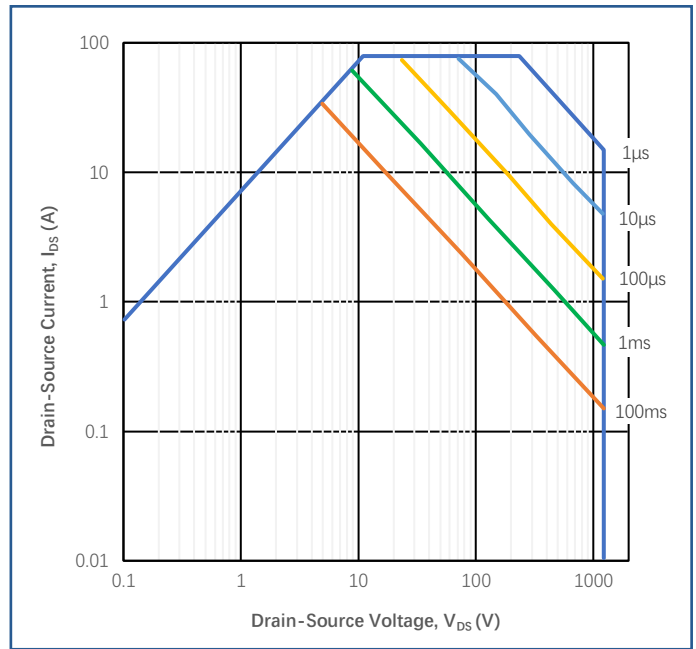
**Fig 15**  
Switching Energy vs. Temperature



**Fig 16**  
Switching Times vs.  $R_{G(\text{ext})}$



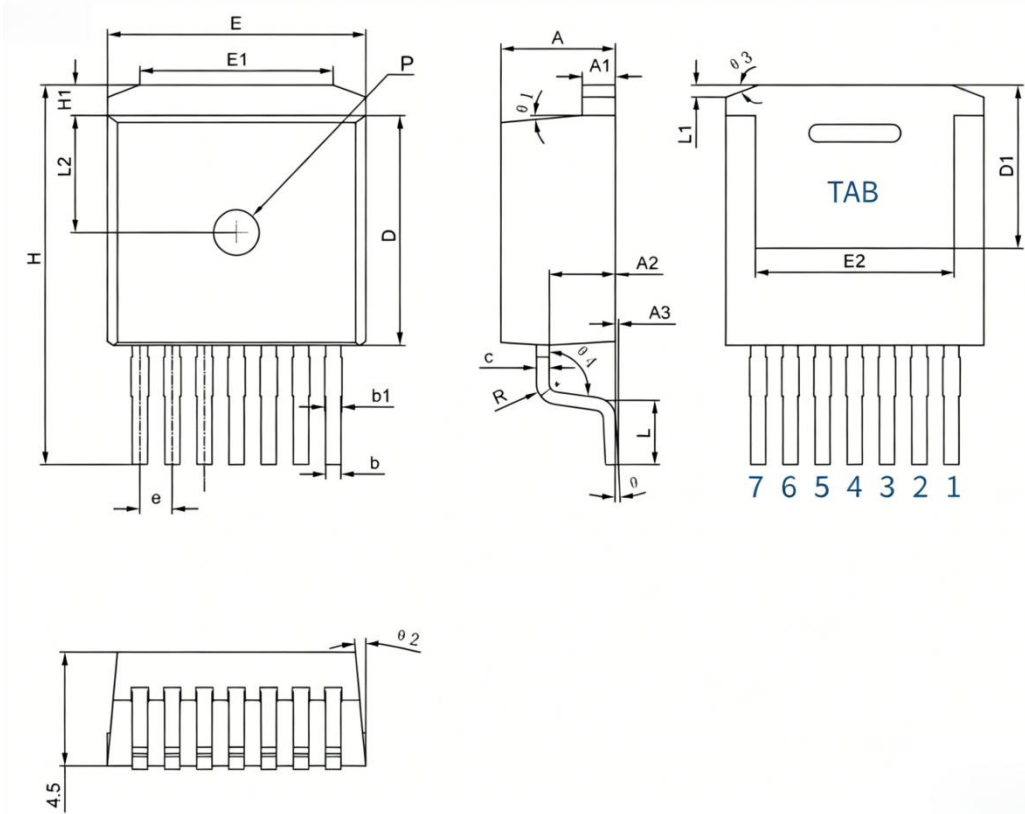
**Fig 17**  
 Transient Thermal Impedance



**Fig 18**  
 Safe Operating Area

Package Outlines(Unit:mm)

TO-263-7L



Symbol	Millimeters			Symbol	Millimeters		
	Min.	Type.	Max.		Min.	Type.	Max.
<b>A</b>	4.40	4.50	4.60	<b>e</b>	1.17	1.27	1.37
<b>A1</b>	1.25	1.30	1.40	<b>H</b>	14.75	15.00	15.25
<b>A2</b>	2.45	2.60	2.70	<b>H1</b>	1.10	1.20	1.30
<b>A3</b>	0.05	0.13	0.20	<b>L</b>	2.35	2.55	2.75
<b>b</b>	0.50	0.60	0.70	<b>L1</b>	0.37	0.57	0.77
<b>b1</b>	0.60	0.70	0.85	<b>L2</b>	4.48	4.63	4.78
<b>c</b>	0.45	0.50	0.60	<b>θ</b>	0°	3°	5°
<b>D</b>	8.88	9.08	9.28	<b>θ1</b>	3°	5°	7°
<b>D1</b>	6.25	6.45	6.65	<b>θ2</b>	3°	5°	7°
<b>E</b>	9.88	10.18	10.28	<b>θ3</b>	15°	20°	25°
<b>E1</b>	6.67	7.07	7.47	<b>R</b>	0.75	0.80	0.85
<b>E2</b>	7.67	7.82	7.97	<b>P</b>	1.70	1.80	1.90

Pin	Symbol	Description
1	G	Gate
2	KS	Driver Source
3-7	S	Power Source
TAB	D	Drain

**Note:**

1. All metal surfaces are Sn plated (matte), except area of cut.
2. Burr or mold flash size (0.5 mm) is not included in the dimensions.

**\*Important Usage Information and Disclaimer**

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